Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/971,984	LAIS ET AL.	
Examiner	Art Unit	
Ted M. Wang	2634	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	341	5/16/2005	1
	260		
	260 340 316		
•	316		
714	796		
386	131		
700	1 6-1		
370	477		
	477 537		
		·	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

E EXM
005